

Extraction of the Michel parameter, ρ , of normal muon decay

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Reconstruction code output

Physics variables

Decay e^+ momentum, $|\vec{p}|$

Decay e^+ $\cos \theta$

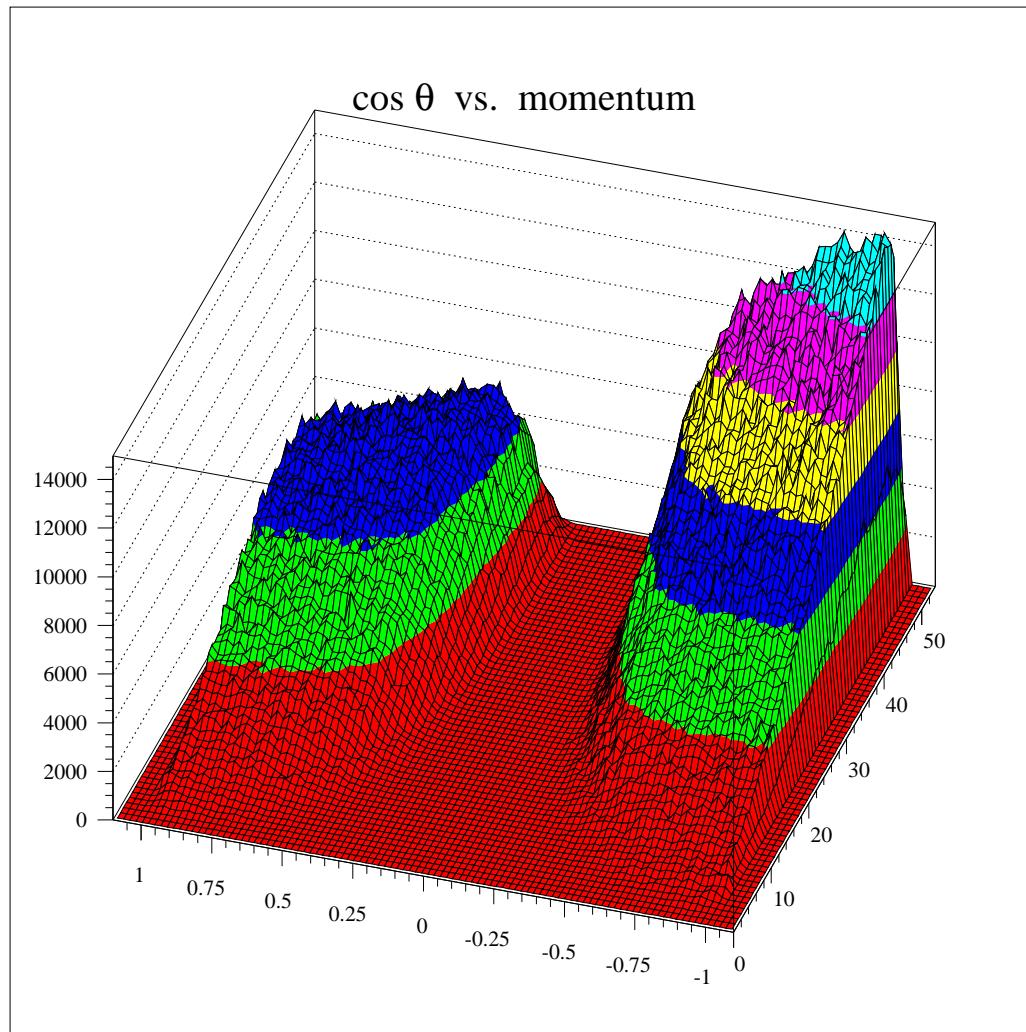
Variables for cuts

Particle time of flight

μ^+ stopping location

Fitter results

Histogram in bins of $|\vec{p}|$ and $\cos \theta$



17% of standard data set

Fitting ρ

The energy and angular distribution of the Michel positron is given by:

$$\frac{d^2\Gamma}{dxd(\cos\theta)} \propto F_{IS}(x, \rho, \eta) + P_\mu \cos\theta F_{AS}(x, \xi, \delta)$$

Where

$$F_{IS} = x^2(1-x) + \frac{2}{9}\rho x^2(4x-3) + \eta \frac{m_e}{E_e^{max}} x(1-x)$$

$$F_{AS} = \frac{1}{3}\xi x[1-x + \frac{2}{3}\delta(4x-3)]$$

Fitting ρ

Integrating over $\cos \theta$ or computing Forward + Backward yields:

$$\frac{d\Gamma}{dx} \propto F_{IS}(x, \rho, \eta) + \epsilon P_\mu F_{AS}(x, \xi, \delta)$$

Where ϵ represents an unknown reconstruction asymmetry.

Note that the effect of $F_{AS}(x, \xi, \delta)$ can be reduced by minimizing ϵ and/or P_μ .

Fitting $\Delta\rho$ and $\Delta\eta$

$$\left[\frac{d\Gamma}{dx} \right]_{Data} = \left[\frac{d\Gamma}{dx} \right]_{Std}$$

$$+ \frac{\partial}{\partial \rho} \left[\frac{d\Gamma}{dx} \right]_{Std} \Delta\rho + \frac{\partial}{\partial \eta} \left[\frac{d\Gamma}{dx} \right]_{Std} \Delta\eta + \frac{\partial}{\partial \xi} \left[\frac{d\Gamma}{dx} \right]_{Std} \Delta\xi + \frac{\partial}{\partial \delta} \left[\frac{d\Gamma}{dx} \right]_{Std} \Delta\delta$$

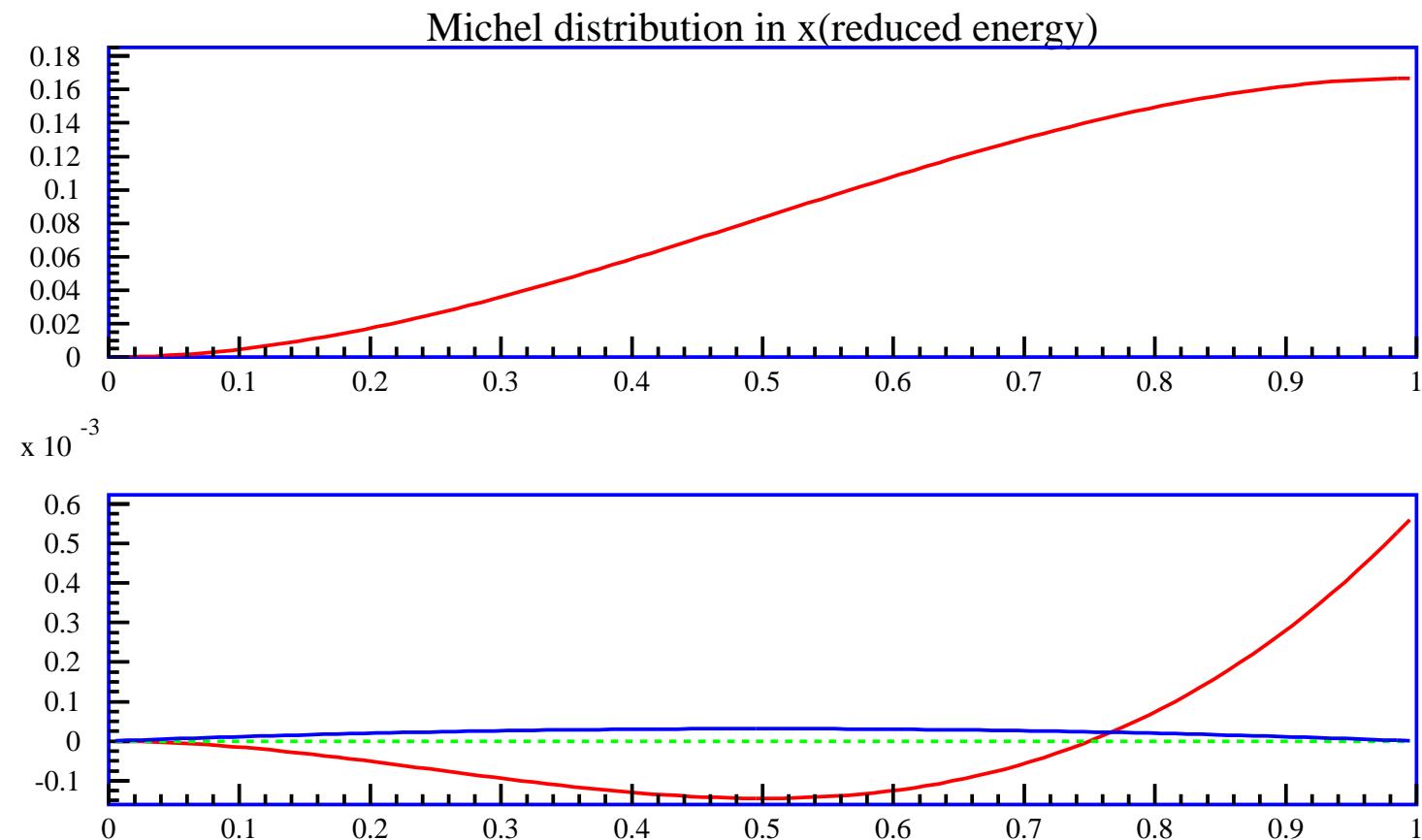
Where

$$\frac{\partial}{\partial \rho} \left[\frac{d\Gamma}{dx} \right]_{Std} = k \frac{\partial}{\partial \rho} \left[F_{IS}(x, \rho, \eta) \right]_{Std}$$

$$\frac{\partial}{\partial \eta} \left[\frac{d\Gamma}{dx} \right]_{Std} = k \frac{\partial}{\partial \eta} \left[F_{IS}(x, \rho, \eta) \right]_{Std}$$

$$\frac{\partial}{\partial \xi} \left[\frac{d\Gamma}{dx} \right]_{Std} = \epsilon P_\mu k \frac{\partial}{\partial \xi} \left[F_{AS}(x, \xi, \delta) \right]_{Std}$$

$$\frac{\partial}{\partial \delta} \left[\frac{d\Gamma}{dx} \right]_{Std} = \epsilon P_\mu k \frac{\partial}{\partial \delta} \left[F_{AS}(x, \xi, \delta) \right]_{Std}$$



Standard Model(top), $\Delta\rho$ (bottom, red), $\Delta\eta$ (bottom, blue)

Fitting ρ with a blind analysis
 (Ignoring $\cos \theta$ term)

Consider

$$\rho = \rho_{Std} + \Delta\rho \quad \rightarrow \quad \rho = \rho_o + \Delta\rho'$$

$$\eta = \eta_{Std} + \Delta\eta \quad \rightarrow \quad \eta = \eta_o + \Delta\eta'$$

Fitting $\Delta\rho'$ and $\Delta\eta'$

$$\left[\frac{d\Gamma}{dx} \right]_{Data} = \left[\frac{d\Gamma}{dx} \right]_{\rho_o, \eta_o} + \frac{\partial}{\partial \rho} \left[\frac{d\Gamma}{dx} \right]_{\rho_o, \eta_o} \Delta\rho' + \frac{\partial}{\partial \eta} \left[\frac{d\Gamma}{dx} \right]_{\rho_o, \eta_o} \Delta\eta'$$

Where

$$\frac{\partial}{\partial \rho} \left[\frac{d\Gamma}{dx} \right]_{\rho_o, \eta_o} = k \frac{\partial}{\partial \rho} \left[F_{IS}(x, \rho, \eta) \right]_{\rho_o, \eta_o} \quad \frac{\partial}{\partial \eta} \left[\frac{d\Gamma}{dx} \right]_{\rho_o, \eta_o} = k \frac{\partial}{\partial \eta} \left[F_{IS}(x, \rho, \eta) \right]_{\rho_o, \eta_o}$$

Systematic errors

Reconstruction efficiency as a function of $\cos \theta$, $|\vec{p}|$
and . . .

DC HV (track fitting)

PC HV (pattern recognition)

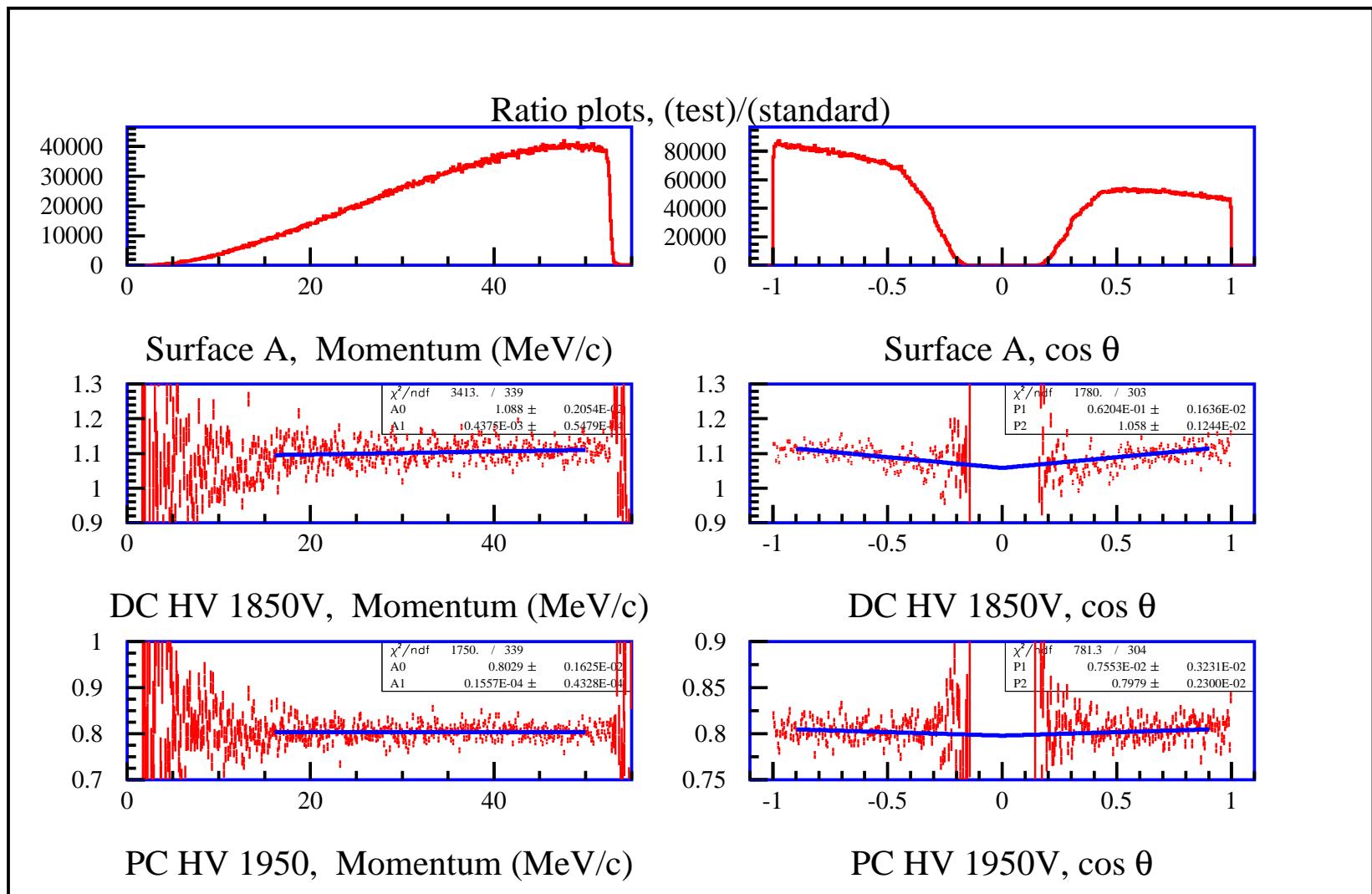
Chamber gas density

μ^+ rate

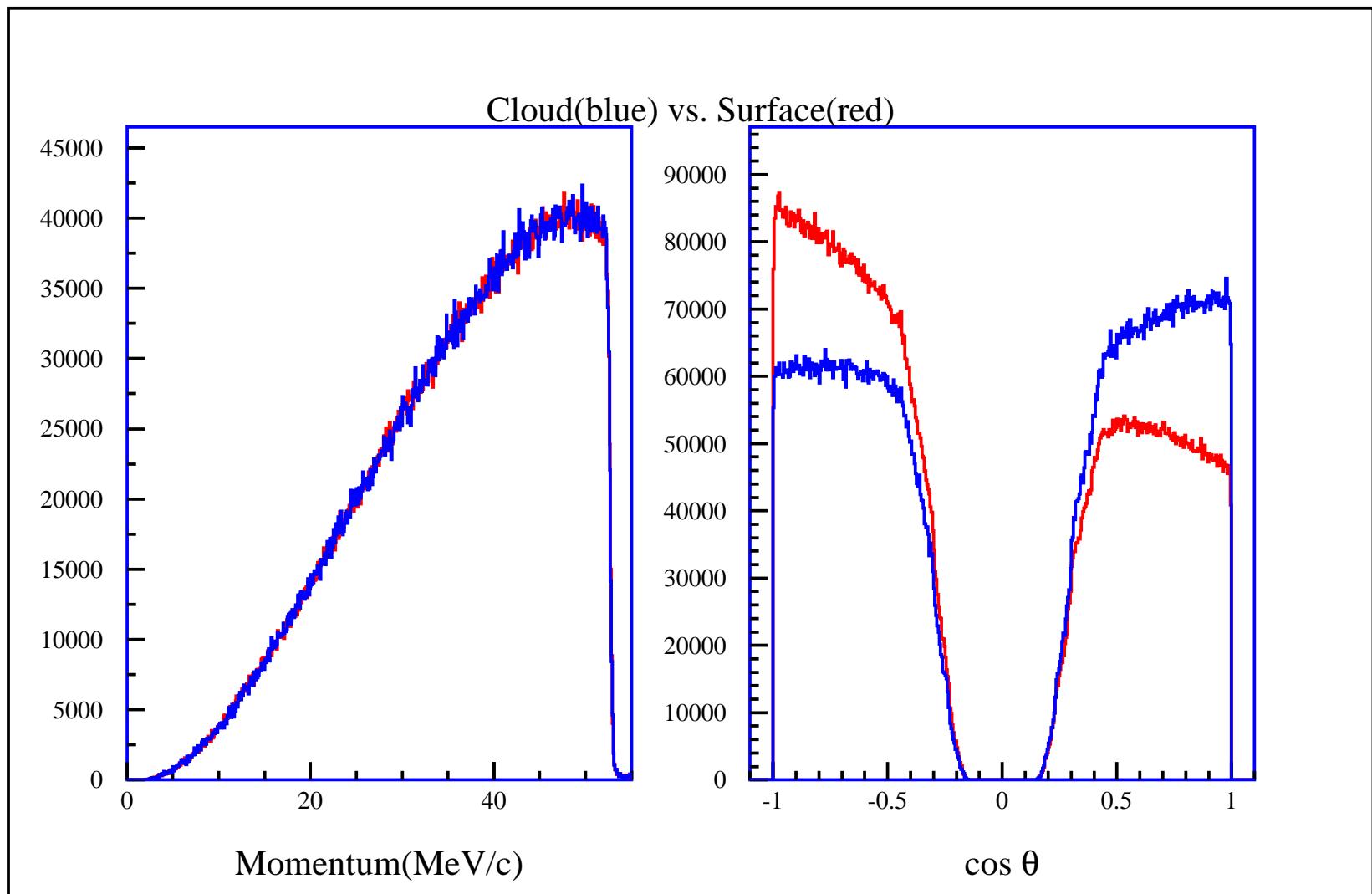
Beam e^+ rate

Upstream/downstream asymmetry*

Philosophy: exaggerate a possible source of error to put limits on its effect.



Surface(17% of standard data set), DC HV 1850V(19%), PC HV 1950V(14%)



Surface(17% of standard data set), Cloud(6%)

Summary

Data has been taken for a measurement of ρ with a statistical precision of a part in 10^3 .

Data with comparable statistics has been taken to study a variety of possible systematic effects.

\mathcal{TWIST} is setting limits on systematic effects by using data to data comparisons

\mathcal{TWIST} is employing an effective blind analysis technique